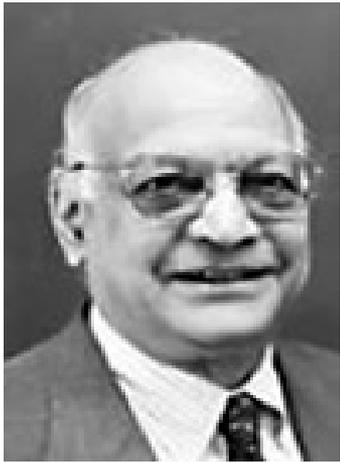


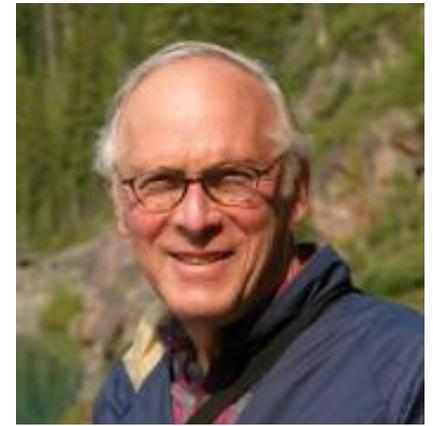
N.F. Mott



V. Ambegaokar



J. Langer



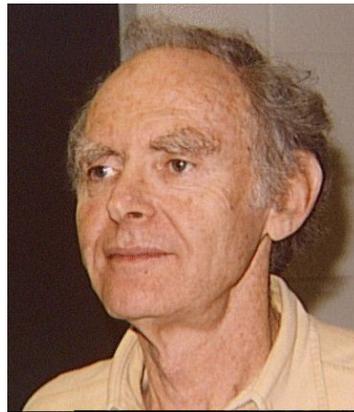
B.I. Halperin



M. Pollak



E. Abrahams



B. Spivak





B.I. Shklovskii A.L. Efros

Electronic Properties of Doped Semiconductors

Springer-Verlag
Berlin Heidelberg New York Tokyo 1984



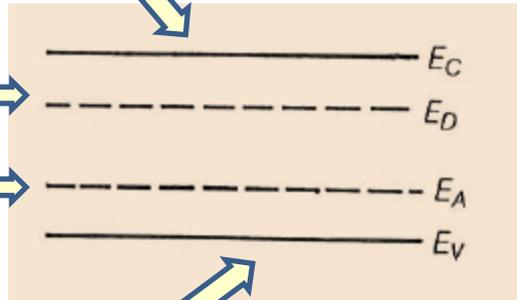
Lecture 1

Topics:

- 1. Impurity states in semiconductors*
- 2. Basic experimental facts*
- 3. Impurity band structure*
- 4. Electron transition between two localized states*
- 5. Mott's law*
- 6. Miller-Abrahams random resistor network*
- 7. Percolation treatment*
- 8. Spin relaxation in the hopping regime*

Impurity levels inside a forbidden gap

bottom of conduction band



energy spectrum of conduction band

$$\left[E_j(-i\nabla) - \frac{e^2}{\kappa r} \right] F_j(\mathbf{r}) = E F_j(\mathbf{r})$$

envelope of the donor wave function

binding energy

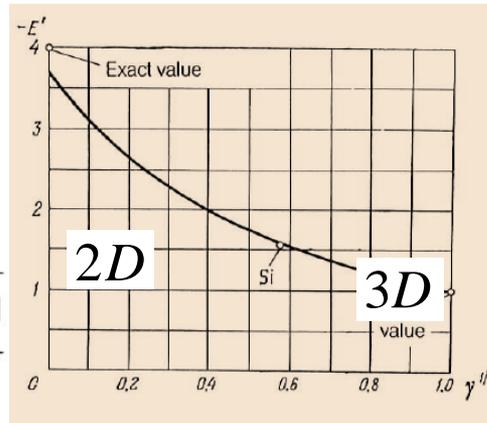
binding energy in the units of $E_t = \hbar^2/2m_t a_t^2$

$$a_t = \hbar^2 \kappa / e^2 m_t$$

for anisotropic spectrum:

$$E(\mathbf{p}) = \frac{p_x^2 + p_y^2}{2m_t} + \frac{p_z^2}{2m_l}$$

Material	E_{1s} , [meV]	E_{2p_0} , [meV]	
Si (theor)	31.27		11.51
Si (P)	45.5	33.9	32.6
Si (As)	53.7	32.6	31.2
Si (Sb)	42.7	32.9	30.6
Ge (theor)	9.81		4.74
Ge (P)	12.9	9.9	4.75
Ge (As)	14.17	10.0	4.75
Ge (Sb)	10.32	10.0	4.74



asymptotic behavior of the envelope at large distances

$$F(\vec{r}) \propto \int d\vec{p} \frac{\exp\left[\frac{i}{\hbar} \vec{p} \cdot \vec{r}\right]}{|E| + E(\vec{p})}$$

$$\gamma = m_t/m_l$$

$$F(\vec{r}) \propto \exp\left[-\left(\frac{2|E|}{\hbar} (m_t z^2 + m_t x^2 + m_t y^2)\right)^{1/2}\right]$$

Table 1.2. Donor ionization energies in Ge and Si. Theoretical values were calculated in the effective-mass approximation. Experimental values correspond to the impurities indicated in parentheses. Energies of all s-state levels, split due to the chemical shift, are listed separately

Electrical Properties of Germanium Semiconductors at Low Temperatures*

H. FRITZSCHE

Department of Physics, Purdue University, Lafayette, Indiana

(Received April 11, 1955)

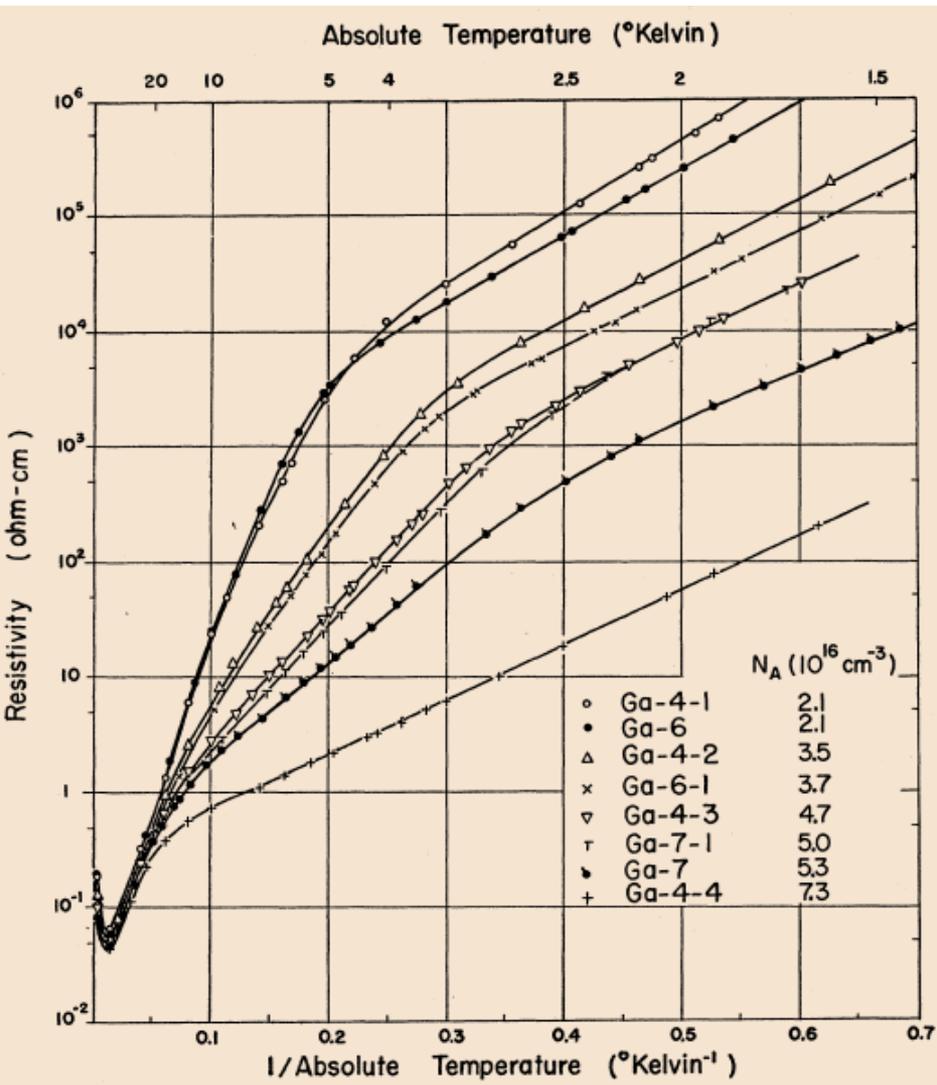


FIG. 8. Resistivity measurements of p-type germanium with large concentrations of gallium.

The resistivity can be described approximately by the equation¹⁰

$$1/\rho = C_1 e^{-\epsilon_1/kT} + C_3 e^{-\epsilon_3/kT},$$

with $\epsilon_1 \approx 1 \times 10^{-2}$ ev and $\epsilon_3 \approx 2 \times 10^{-3}$ ev.

$$\frac{\epsilon_1}{T} = 10 \iff T = 10K \iff \frac{\epsilon_3}{T} = 2$$

$\exp\left[-\frac{\epsilon_1}{T}\right]$ dominates

$$\frac{\epsilon_1}{T} = 50 \iff T = 2K \iff \frac{\epsilon_3}{T} = 10$$

$\exp\left[-\frac{\epsilon_3}{T}\right]$ dominates

The explanation of these observations due to Hung, who assumed that the localized impurity states interact and form a conduction band, seems plausible for the following reasons. The width of the impurity band should drastically decrease with increasing separation between the impurity atoms. Therefore one would expect the mobility of the charge carriers in the impurity band to decrease rapidly with decreasing concentration of impurities. This effect is demonstrated by the

Anisotropic Electrical Properties of Amorphous Germanium

J. J. Hauser

Bell Laboratories, Murray Hill, New Jersey 07974

(Received 21 June 1972)

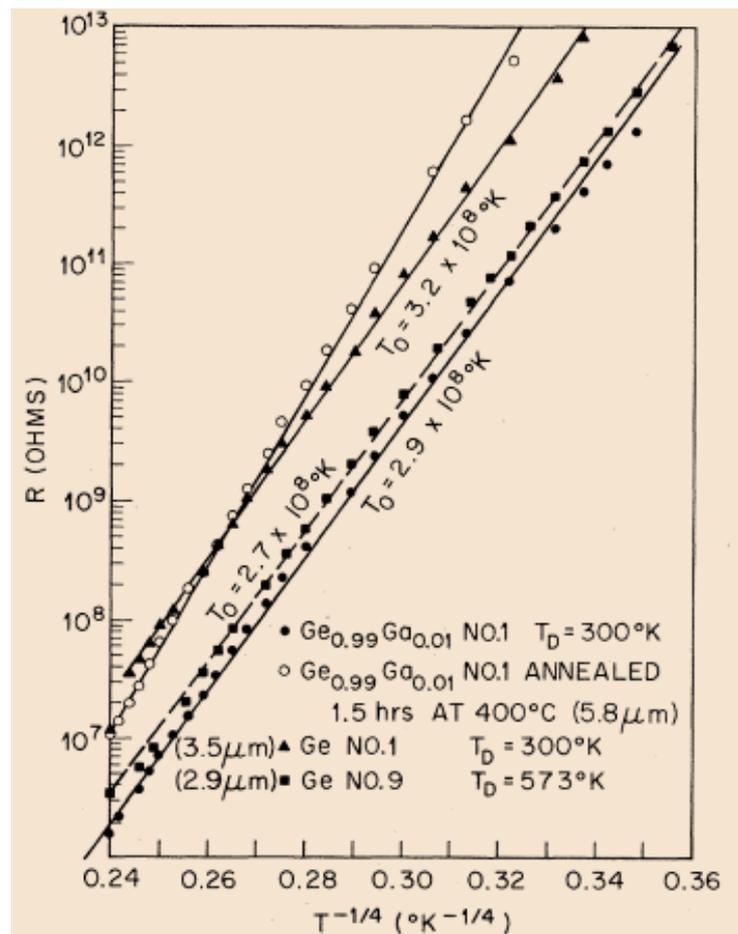
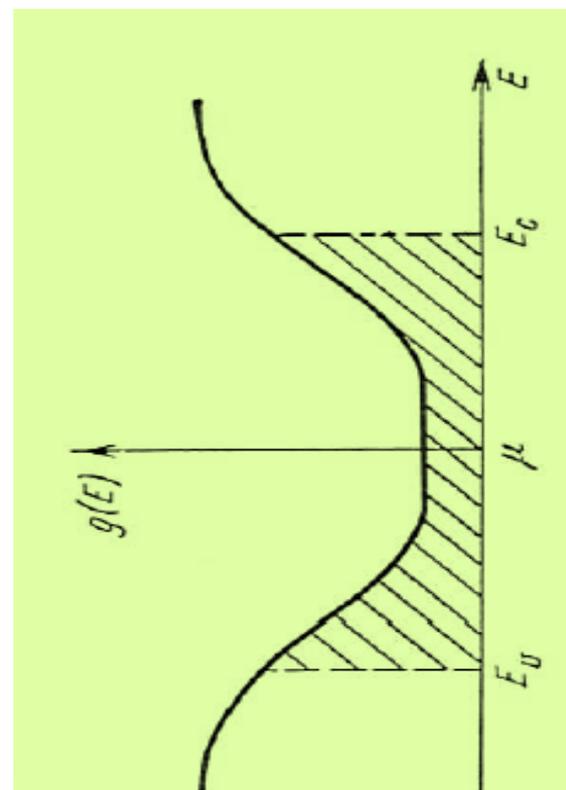


FIG. 1. Temperature dependence of the planar resistance for films deposited at and above 300°K. $\text{Ge}_{0.99}\text{Ga}_{0.01}$ sample No. 1, $d=5.8 \mu\text{m}$, $\rho_{RT}=600 \Omega \text{ cm}$; Ge sample No. 1, $d=3.5 \mu\text{m}$, $\rho_{RT}=1500 \Omega \text{ cm}$; Ge sample No. 9, $d=2.86 \mu\text{m}$, $\rho_{RT}=600 \Omega \text{ cm}$.

$$\rho = \rho_0 \exp\left[\left(T_0/T\right)^{1/4}\right]$$

$$\approx 40$$



Mott-Anderson Localization in the Two-Dimensional Band Tail of Si Inversion Layers

D. C. Tsui and S. J. Allen, Jr.

Bell Laboratories, Murray Hill, New Jersey 07974

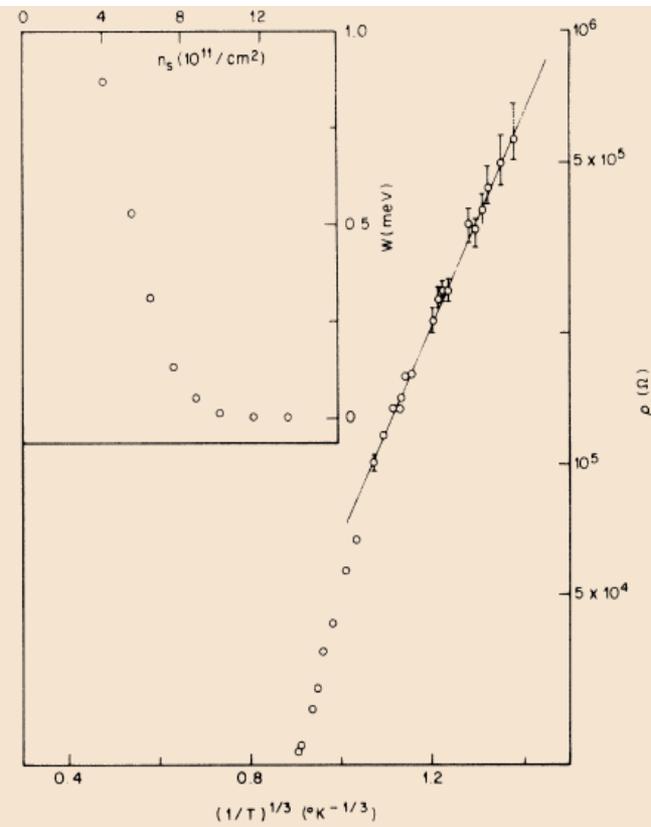
(Received 31 January 1974)

Experimental evidence for a transition from localized to extended states in a two-dimensional band tail is obtained by measuring the conductivity in *n*- and *p*-type inversion layers in Si as a function of electron density and temperature (4.2 to 0.4°K). A transition from metallic to thermally activated conductivity is observed as a function of electron density, while the temperature dependence at electron densities below the transition shows both thermally activated nearest-neighbor hopping and variable-range hopping as proposed by Mott.

FIG. 2. $\ln\rho$ versus $(1/T)^{1/3}$ at $n_s = 6.4 \times 10^{11}/\text{cm}^2$. The slope of the solid line gives the parameter $T_0 = 177^\circ\text{K}$. The inset shows the activation energy W as a function of n_s .

In Fig. 2, the data for $n_s = 6.4 \times 10^{11}/\text{cm}^2$ are replotted on a $\ln\rho$ -versus- $(1/T)^{1/3}$ scale. It is clear that ρ follows the $\exp[(T_0/T)^{1/3}]$ dependence on T for $T \lesssim 1^\circ\text{K}$. However, the temperature range is much too limited to determine unambiguously the correct power of $1/T$.

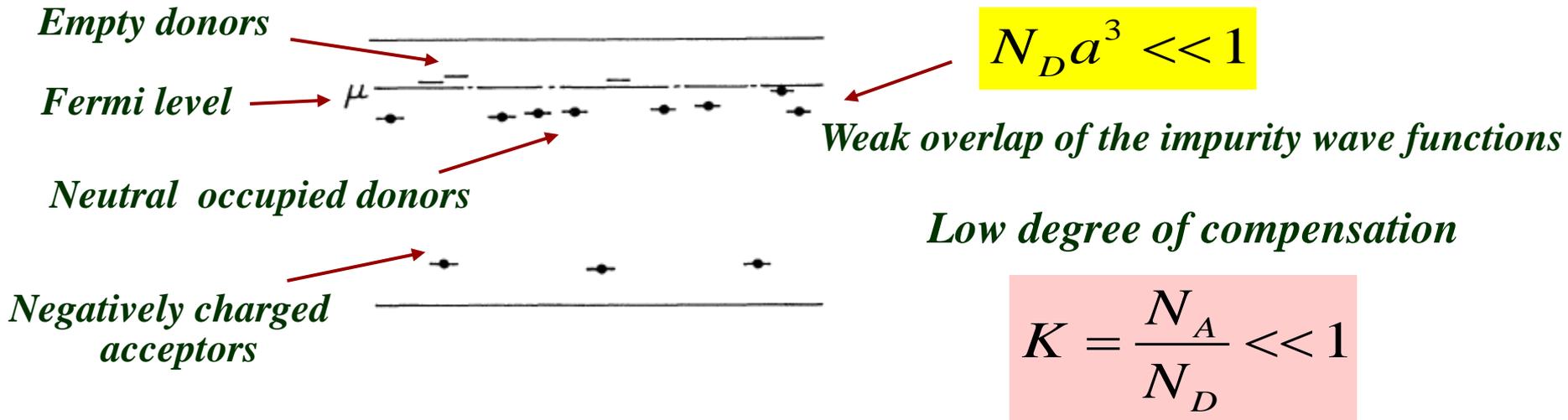
The parameter T_0 deduced from our data is 500°K for $n_s = 5.2 \times 10^{11}/\text{cm}^2$ and 180°K for $n_s = 6.4 \times 10^{11}/\text{cm}^2$. According to Mott's argument, $T_0 \approx 27\alpha^2/\pi k\eta$ in the case of a 2D system. Here k is the Boltzmann constant and α^{-1} is the range of the localized state. Our data yield $\alpha^{-1} \approx 110 \text{ \AA}$ for $n_s = 5.2 \times 10^{11}/\text{cm}^2$ and $\approx 180 \text{ \AA}$ for $n_s = 6.4 \times 10^{11}/\text{cm}^2$. We can also estimate α^{-1} from $\alpha(E_F) \approx [2m^*(E_c - E_F)/\hbar^2]^{1/2}$. Using $m^* = 0.2m_0$ and $E_F = n_s/\eta$, we obtain $\alpha^{-1} \approx 80 \text{ \AA}$ for $n_s = 5.2 \times 10^{11}/\text{cm}^2$ and $\alpha^{-1} \approx 100 \text{ \AA}$ for $n_s = 6.4 \times 10^{11}/\text{cm}^2$.



$$T = 1\text{K}$$

$$\left(\frac{T_0}{T}\right)^{1/3} = 8$$

Lightly doped



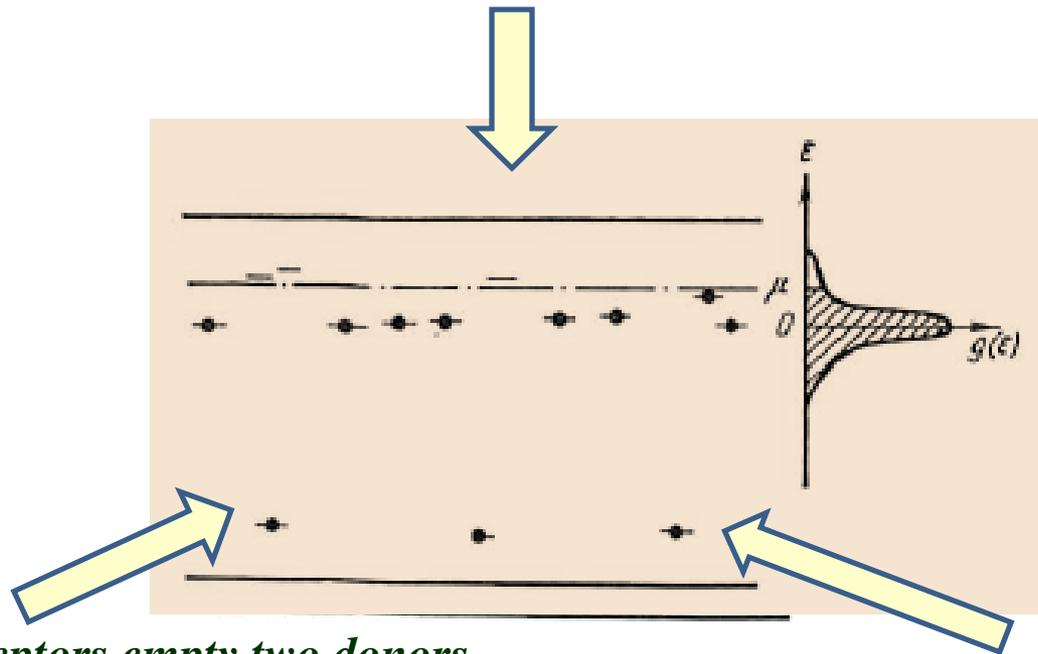
μ is determined from the condition that K percent of donors

with energies $\epsilon_i > \mu$ are empty

Acceptors shift the level up Empty donors shift the level down

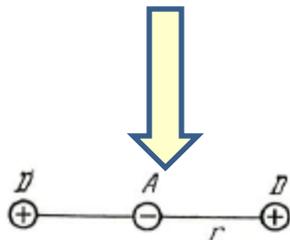
$$\epsilon_i = \frac{e^2}{\kappa} \left[\sum_e^{\text{acc}} \frac{1}{|r_i - r_e|} - \sum_{k \neq i}^{\text{don}} \frac{1 - n_k}{|r_i - r_k|} \right]$$

Typically, an empty donor is the nearest neighbor of an acceptor



*Some acceptors empty two donors
in their neighborhood- **2 complex***

*Some acceptors do not have a donor
in the neighborhood- **0 complex***



Neutrality condition:

$$N_0(\mu) = N_2(\mu)$$

*Positive energy shift by acceptor overweighs
negative energy shift by second donor*

increases

decreases

For 0-complex to exist there must be no donors in a sphere

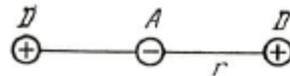
with radius $r_\mu = e^2/\kappa\mu$ around a fixed acceptor

$$N_0(\mu) = N_A \exp\left[-\frac{4\pi}{3} \frac{e^6 N_D}{\kappa^3 \mu^3}\right]$$

Shift by acceptor Shift by donor

$$\epsilon_1 = \frac{e^2}{\kappa|\mathbf{r}_1|} - \frac{e^2}{\kappa|\mathbf{r}_1 - \mathbf{r}_2|}$$

2-complexes



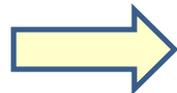
$$\epsilon_2 = \frac{e^2}{\kappa|\mathbf{r}_2|} - \frac{e^2}{\kappa|\mathbf{r}_1 - \mathbf{r}_2|}$$

$$N_2^>(\mu) = N_A N_D^2 \int d\mathbf{r}_1 \int_{r_2 > r_1} d\mathbf{r}_2 \Theta[\epsilon_1(\mathbf{r}_1, \mathbf{r}_2) - \mu] \Theta[\epsilon_2(\mathbf{r}_1, \mathbf{r}_2) - \mu]$$

probability that two donors are the nearest neighbors of the acceptor

$$N_2^< = N_A N_D^2 \int d\mathbf{r}_1 \int_{r_1 < r_2} d\mathbf{r}_2 \exp\left[-\frac{4\pi}{3} N_D r_2^3\right] \Theta[\epsilon_1(\mathbf{r}_1, \mathbf{r}_2) - \mu] \Theta[\epsilon_2(\mathbf{r}_1, \mathbf{r}_2) - \mu]$$

$$N_0(\mu) = N_2(\mu)$$

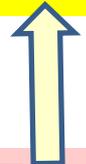


$$\mu = 0.61 \epsilon_D = 0.99 e^2 N_D^{1/3} / \kappa$$

0-complexes constitute **1.3%** of the acceptor concentration

Temperature dependence of the *nearest-donor* hopping conductivity

$$\exp\left(-\frac{\mu}{T}\right) = \exp\left(-\frac{0.99e^2 N_D^{1/3}}{\kappa T}\right)$$



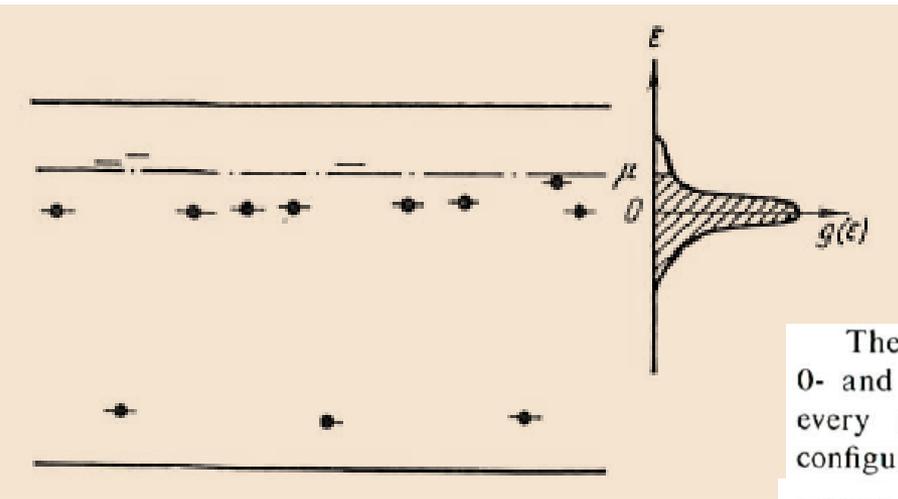
probability that at $T \ll \mu$ a donor is empty

condition $N_D a^3 \ll 1$ ensures that $\mu \ll \frac{\hbar^2}{ma^2}$ \Rightarrow impurity band is narrow

Width of the density-of-states peak is determined by long-range fluctuations

$$\gamma = 2\sqrt{2\pi} \frac{e^2}{\kappa r_0} (N_0 r_0^3)^{1/2} = 0.26 \epsilon_D (N_A/N_D)^{1/4}$$

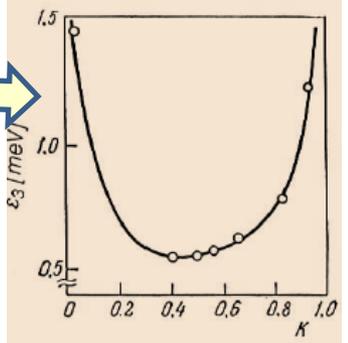
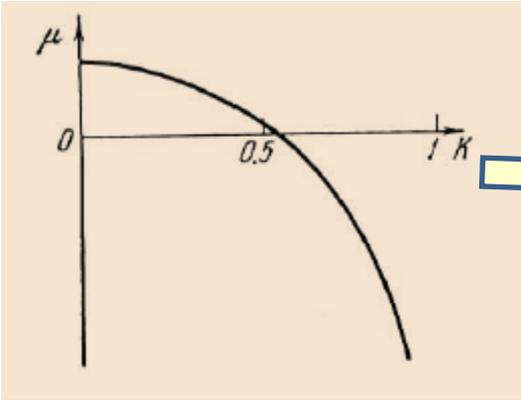
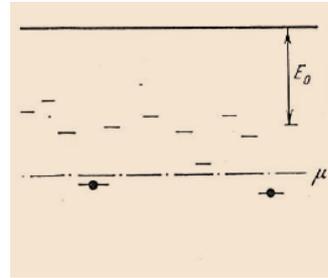
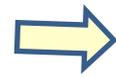
$$r_0 = 0.58 N_A^{-1/2} N_D^{1/6}$$



These figures may tempt one to think that in the first approximation both 0- and 2-complexes can be ignored. However, this would be incorrect. If every acceptor produced a 1-complex, such complexes would include configurations where the nearest donor is far from its acceptor. The site energy ϵ for such a donor is almost zero. But this donor must be ionized, since we are dealing with a 1-complex, and hence we would have $\mu=0$ rather than $0.61\epsilon_D$. Thus it is not permissible to neglect the 0- and 2-complexes in calculating the Fermi level.

With increasing

K



I. Close pairs of donors:

$$dN = 4\pi N_D R^2 dR$$

$$\epsilon = \frac{e^2}{\kappa R}$$

$$g(\epsilon) = \frac{dN}{d\epsilon}$$

$$g(\epsilon) = \frac{3}{2} \frac{\epsilon_D^3}{\epsilon^4} N_D$$

$$\int_{-\infty}^{\mu} g(\epsilon) d\epsilon = n$$

II. Long-range fluctuations:

Fluctuation of number of donors in a cube with side

r

$$\mu \sim \frac{e^2 (N_D r^3)^{1/2}}{r}$$

r is determined by the condition:

$$\frac{(N_D r^3)^{1/2}}{r^3} \sim n = N_D (1 - K)$$

excess concentration of charges

$$\mu = - \left(\frac{2\pi}{3} \right)^{1/3} \frac{e^2 N_D^{2/3}}{\kappa n^{1/3}} = - \frac{\epsilon_D}{2^{1/3} (1-K)^{1/3}}$$

yields the same result

for **mu**

At $T=0$ electrons tend to occupy states of lowest energy. Therefore they will move into regions with a positive impurity charge. If the excess impurity density ΔN is lower than the average electron density n , then the fluctuations will be completely neutralized by a small variation in the electron density. If, on the other hand, $\Delta N \gg n$, the fluctuations cannot be neutralized by electrons at all. Indeed, even if all electrons moved from negative regions, their density in the positive regions would only double, still remaining small compared to the impurity charge.

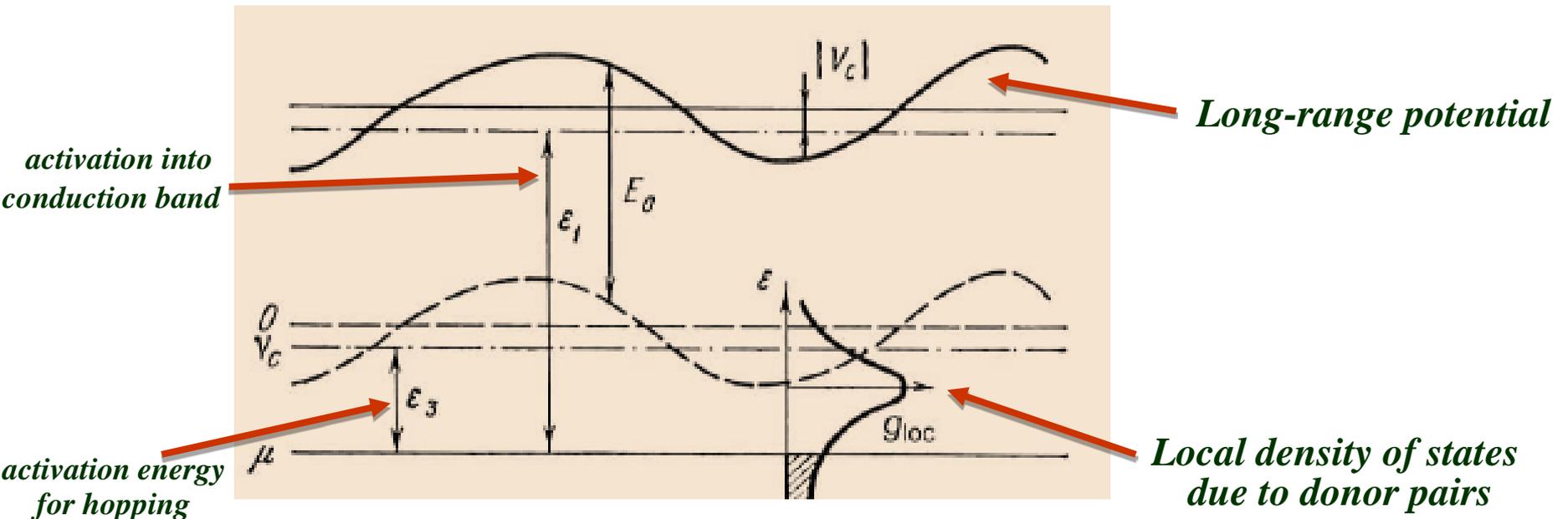
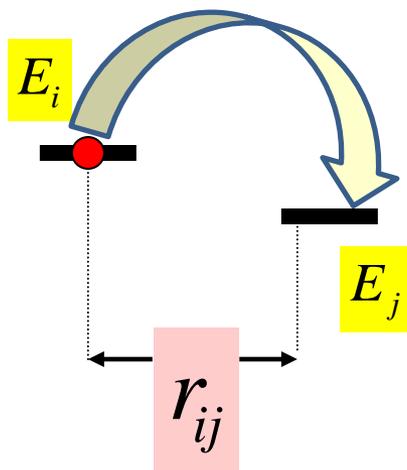


Fig. 3.5. Energy diagram of a highly compensated semiconductor, taking the long-range potential relief into account. Meandering lines (solid and dashed) represent the bottom of the conduction band and the impurity ground-state energy, both following the behavior of the potential energy $V(\mathbf{r}) = -e\phi$. The straight solid line on the top and dashed line correspond to these unperturbed energies. The Fermi level is shown by a solid line at the bottom. Also shown is the local density of states at some point in space. The region of occupied states is shaded. The dash-dotted lines correspond to the percolation levels (Sect. 5.2); ϵ_1 and ϵ_2 are the activation energies (Sect. 8.2)

Phonon-assisted transition between two sites:



Golden rule

sound velocity

phonon wave vector

$$\gamma_{ij} = \frac{2\pi}{\hbar} \frac{V_0}{(2\pi)^3} \int |M_{\mathbf{q}}|^2 \delta(\hbar s_{\mathbf{q}} - \Delta_{ij}^j) d\mathbf{q}$$

overlap integral

$E_i - E_j$

$$\Psi'_i = \Psi_i + \frac{I_{ij}}{\Delta_{ij}^j} \Psi_j$$

$$\Psi'_j = \Psi_j - \frac{I_{ij}}{\Delta_{ij}^j} \Psi_i$$

$$\gamma_{ij} = \gamma_{ij}^0 \exp(-2r_{ij}/a) N(\Delta_{ij}^j)$$

Matrix element deformation potential

$$|M_{\mathbf{q}}|^2 = \left(\frac{\hbar q E_1^2}{2dV_0 s} \right) \left(\frac{I_{ij}}{\Delta_{ij}^j} \right)^2 N_{\mathbf{q}} (1 - \cos \mathbf{q} \cdot \mathbf{r}_{ij}) \left[1 + \left(\frac{qa}{2} \right)^2 \right]^{-4}$$

density

Planck distribution

Fourier transform of the donor wave function

Hopping Conductivity in Disordered Systems

Vinay Ambegaokar*

Research Institute for Theoretical Physics, University of Helsinki, Finland

and

B. I. Halperin

Bell Telephone Laboratories, Murray Hill, New Jersey 07974

and

J. S. Langer†

Carnegie-Mellon University, Pittsburgh, Pennsylvania 15213

(Received 14 May 1971)

Resistance corresponding to a single hop

$$I_{12} = \gamma_{12} f\left(E_1 - \frac{V}{2}\right) \left[1 - f\left(E_2 + \frac{V}{2}\right)\right]$$

$$\gamma_{12} = \gamma_{21} \exp\left[\frac{E_1 - E_2}{T}\right]$$

$$I_{21} = \gamma_{21} f\left(E_2 + \frac{V}{2}\right) \left[1 - f\left(E_1 - \frac{V}{2}\right)\right]$$

in equilibrium $V = 0 \implies I_{12} = I_{21}$

at finite $V \ll T \implies I = I_{12} - I_{21} = \frac{V}{R_{12}}$

and $|E_1|, |E_2| \gg T$

where

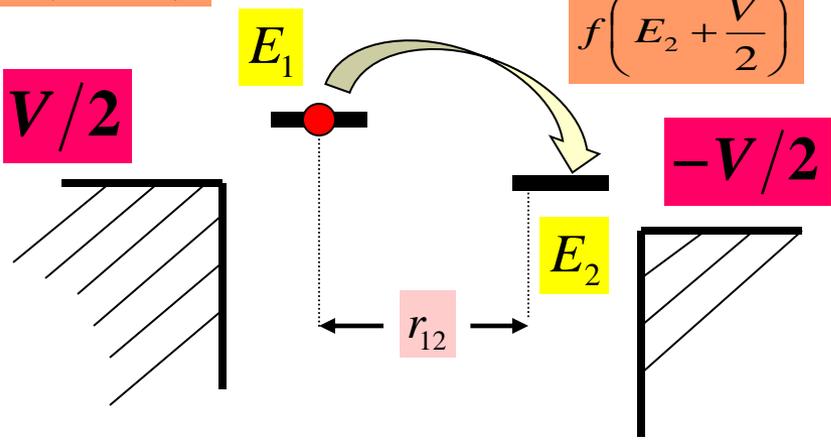
$$R_{12} = R_0 \exp\left[\frac{2r_{12}}{a} + \frac{|E_1| + |E_2| + |E_1 - E_2|}{2T}\right]$$

average occupation

$$f\left(E_1 - \frac{V}{2}\right)$$

average occupation

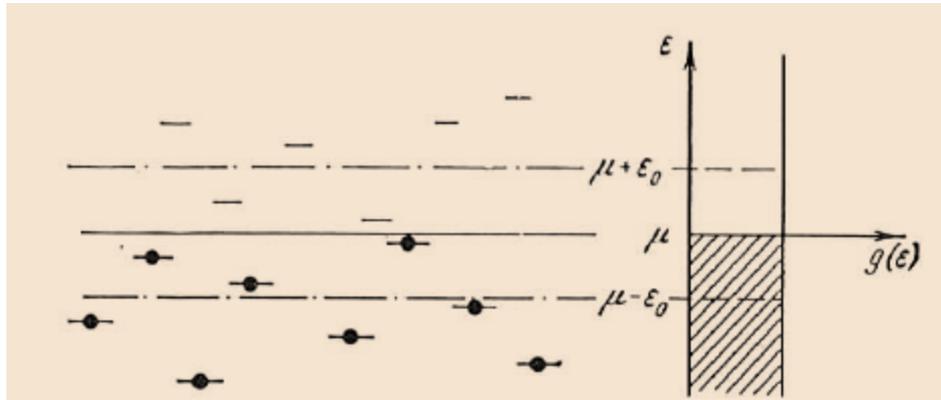
$$f\left(E_2 + \frac{V}{2}\right)$$



$$E_a = |E_1 - E_2| \text{ for } E_1 \cdot E_2 < 0$$

$$E_a = \max\{E_1, E_2\} \text{ for } E_1 \cdot E_2 > 0$$

Mott's law



*constant density of states
within the strip*

$$|\varepsilon_i - \mu| \leq \varepsilon_0$$

*concentration of sites
within the strip*

$$N(\varepsilon_0) = 2g(\mu)\varepsilon_0$$

*Transport resulting from energy
levels within the strip*

$$\frac{\rho}{\rho_0} = \exp \left[\frac{1}{N(\varepsilon_0)^{1/3} a} + \frac{\varepsilon_0}{T} \right] = \exp \left[\frac{1}{(g\varepsilon_0)^{1/3} a} + \frac{\varepsilon_0}{T} \right]$$

$$\varepsilon_0 = \varepsilon_0(T) = \frac{T^{3/4}}{(ga^3)^{1/4}}$$

has a sharp minimum at

$$\ln \left[\frac{\rho(\varepsilon_0(T))}{\rho_0} \right] = \left(\frac{T_0}{T} \right)^{1/4}$$

$$T_0 = \frac{1}{g(\mu)a^3}$$

$$r = [g\varepsilon_0(T)]^{-1/3} = a \left(\frac{T_0}{T} \right)^{1/4}$$

typical hopping distance increases with decreasing T

variable-range hopping

Numerical factor in log-resistance from percolation theory

PHYSICAL REVIEW

VOLUME 120, NUMBER 3

NOVEMBER 1, 1960

Impurity Conduction at Low Concentrations*†

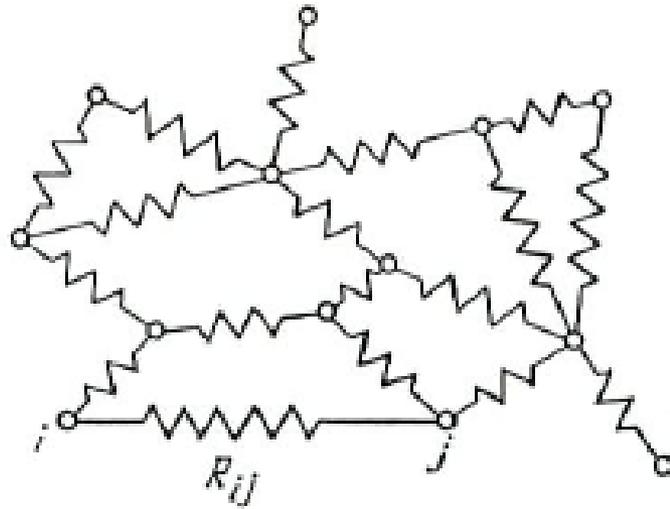
ALLEN MILLER‡ AND ELIHU ABRAHAMS

Physics Department, Rutgers University, New Brunswick, New Jersey

(Received June 23, 1960)

Nearest-neighbor hopping:

tunneling dominates over activation



$$\frac{r}{a} \sim \frac{1}{N_D^{1/3} a} > \frac{\varepsilon}{T} \sim \frac{e^2 N_D^{1/3}}{\kappa T}$$

$$\frac{e^2}{\kappa a} > T > \frac{e^2}{\kappa a} (N_D a^3)^{2/3}$$

$$\ln R_{ij} = \frac{2r_{ij}}{a}$$

The sites with $r_{ij} < r_c$ are connected

Infinite cluster appears when

$$B_c = \frac{4\pi}{3} N_D r_c^3 = 2.7 \pm 0.1$$

$$\ln R = \frac{1.73}{N_D^{1/3} a}$$

average number of neighboring donors

inside a sphere with $r = r_c$

Numerical factor in log-resistance from percolation theory: Variable-range hopping

Bonding criterion

$$\frac{2r_{ij}}{a} + \frac{\epsilon_{ij}}{T} < \xi$$

dimensionless distance

$$s_i = \frac{r}{r_{\max}}$$

$$r_{\max} = \frac{a\xi}{2}$$

$$\epsilon_{\max} = T\xi$$

dimensionless energy

$$\Delta_i = \frac{\epsilon_{ij}}{\epsilon_{\max}}$$

$$s_{ij} = |s_i - s_j| = \frac{r_{ij}}{r_{\max}}$$

$$\Delta_{ij} = \frac{1}{2} [|\Delta_i| + |\Delta_j| + |\Delta_i - \Delta_j|]$$

$$s_{ij} + \Delta_{ij} < 1$$

Dimensionless concentration of sites within energy strip $|\Delta_i| < 1$

$$n(\xi) = 2g\epsilon_{\max}r_{\max}^3 = \frac{gTa^3}{4}\xi^4$$

$$n(\xi) = n_c = 5.3$$

Infinite cluster appears at

In 2D

$$\ln R = \left[\frac{14}{ga^2T} \right]^{1/3}$$

$$\ln R = \left[\frac{21}{ga^3T} \right]^{1/4}$$

Mott's law with numerical factor

$$n_{VRH}^c \int_{\Delta_{ij} < 1} (1 - \Delta_{ij})^3 \frac{d\Delta_i d\Delta_j}{2} = n_{NNH}^c$$

$$= \frac{3}{20}$$

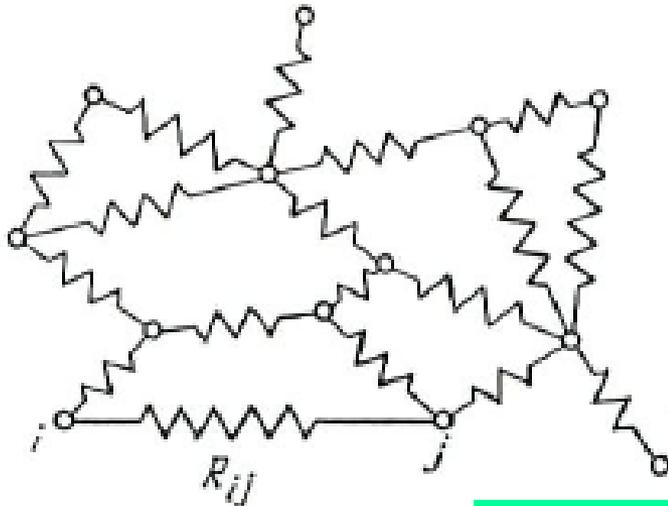
So far we have been dealing with an example of a very complicated anisotropy, namely that of a four-ellipsoid donor state. Another example of an anisotropic wave function whose shape is provided by donor states is germanium subjected to a large uniaxial stress. It is well known [6.17] that under uniaxial compression in the [111] direction, the energy of one of the conduction band minima goes down, while that of the other three minima goes up. At pressures of order 10^9 dyne/cm² this splitting becomes so large that the electron ground state on a donor is no longer associated with all four ellipsoids as it is in the absence of pressure, but with one ellipsoid only. Further increases in pressure essentially produce no new change in the wave function. Therefore the value of order 10^9 dyne/cm² can be called the limiting or "maximal" pressure. At the "maximal" pressure only one term corresponding to a selected ellipsoid remains in the expressions (6.2.1), (6.2.2), and (6.2.7). As a result we obtain an expression of the form (6.2.10) with ξ_{ij} given by

$$\xi_{ij} = 2 \left[\frac{x_{ij}^2 + y_{ij}^2}{a^2} + \frac{z_{ij}^2}{b^2} \right]^{1/2}$$

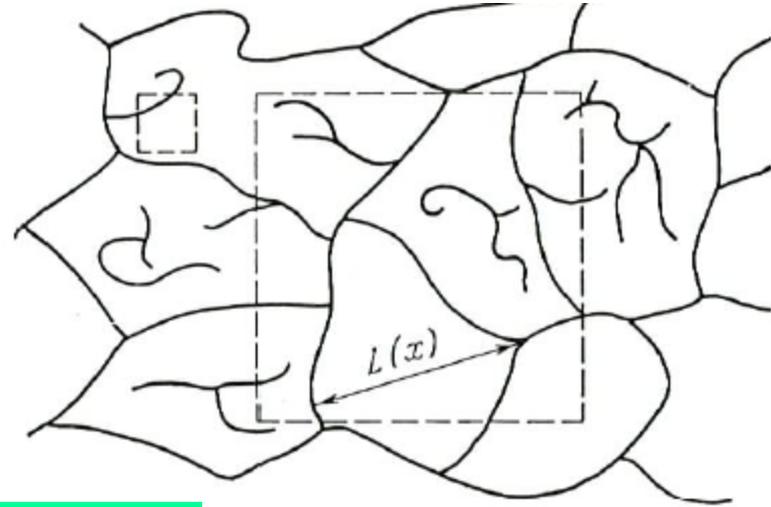
$$N_D \int d\vec{r} \theta(\xi - \xi_{ij}) = B_c$$

$$\ln R = \frac{1.73}{N_D^{1/3} (a^2 b)^{1/3}}$$

Random resistor network



Near the percolation threshold



$$L(\xi) \sim a \xi_c^\nu \left(\frac{\xi_c}{\xi - \xi_c} \right)^\nu$$

hopping length

critical exponent

$$\nu_2 = \frac{4}{3} \quad \nu_3 \approx 0.9$$

Resistance of the sample is dominated by infinite cluster with

$$(\xi - \xi_c) \sim 1$$

“Unit cell” of the current-carrying network

$$L_c \sim a \xi_c^{\nu+1}$$

Hopping transport in amorphous film of a thickness d

$$d \ll a \xi_c = \bar{r} \quad \text{2D Mott's law with}$$

$$T_0 = \frac{\beta}{[g d] a^2}$$

$$d \gg \bar{r}$$

No thickness dependence if d exceeds

$$L_c \sim a \xi_c^{\nu+1}$$

Fig. 9.4. The relation of bulk and film infinite clusters. Dashed lines show the film boundaries, solid lines the parts of the bulk infinite cluster lying within the film. L is the correlation radius, d the film thickness

$$L(\xi_{cd}) = d$$

$$\xi_{cd} = \xi_c \left[1 + D \left(\frac{\bar{r}}{d} \right)^{1/\nu_3} \right]$$

$$\ln \left(\frac{\rho(d)}{\rho(\infty)} \right) = D \left(\frac{T_0}{T} \right)^{1/4} \left(\frac{\bar{r}}{d} \right)^{1/\nu_3}$$

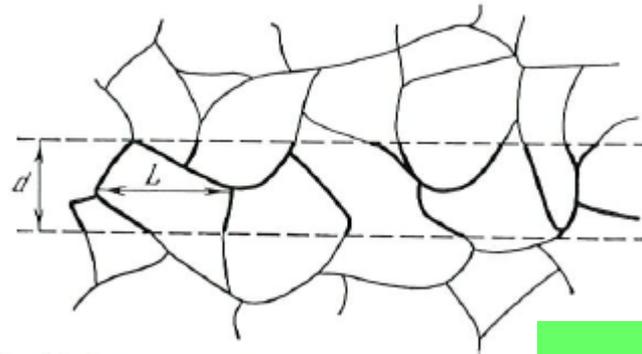
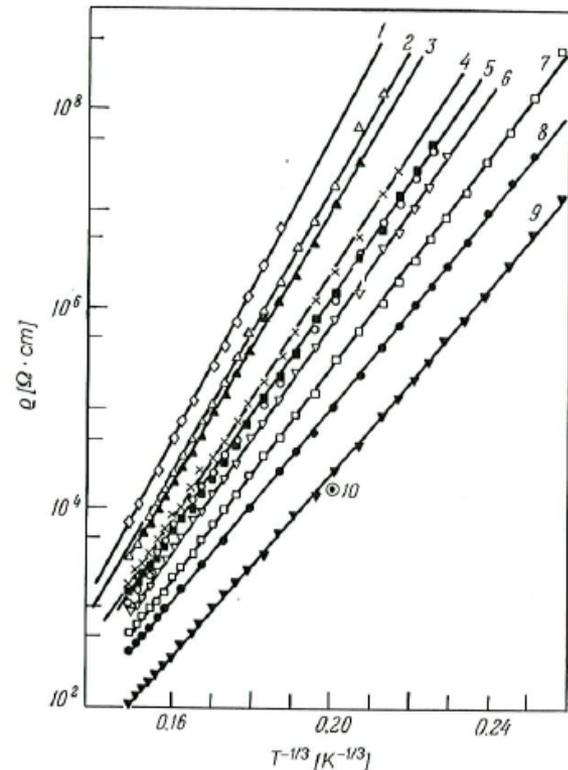


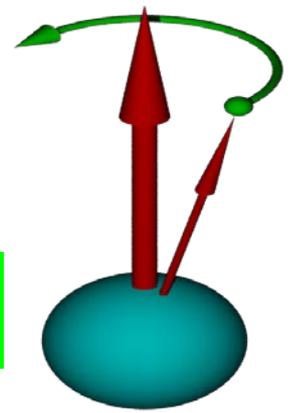
Fig. 9.3. Temperature dependences of the resistivities in amorphous carbon films of varying thickness d . The values of d are (in Å): (1) 150, (2) 200, (3) 170, (4) 225, (5) 250, 300, (6) 275, (7) 400, (8) 575, (9) 1200. Point 10 corresponds to $d = 6890$ Å [9.33]



Dyakonov-Perel spin relaxation in diffusive regime

Over the mean free path $l = v \tau$

electron spin rotates by a random angle $\delta\varphi \ll 1$



Initial spin orientation is forgotten after N steps:

$$N(\delta\varphi)^2 \sim 1 \quad \text{random walk}$$

Spin relaxation time:

$$\tau_s = N\tau = \frac{\tau}{(\delta\varphi)^2}$$

Spin diffusion length:

$$l_s = \sqrt{N}\tau = \frac{l}{\delta\varphi}$$

Relaxation due to spin-orbit coupling:

$$\frac{d\vec{S}}{dt} = \vec{\Omega}_{so} \times \vec{S} \iff \hat{H}_{so} = \vec{\Omega}_{so} \cdot \hat{\sigma}$$

$$\delta\varphi = \Omega_{so} \tau$$

$$\tau_s = \frac{1}{\Omega_{so}^2 \tau}$$

$$l_s = \frac{v}{\Omega_{so}}$$

Dyakonov-Perel spin relaxation near the metal-insulator transition and in hopping transport

B. I. Shklovskii

Department of Physics, University of Minnesota, Minneapolis, Minnesota 55455, USA

for free electrons in conduction band

relation

$$\tau_s = \frac{1}{\Omega_{so}^2 \tau}$$

can be cast in the form

$$\frac{1}{\tau_s} = A \sigma$$

$$A = \frac{m \Omega_{so}^2}{n e^2}$$

Relation holds in the hopping regime

$$\sigma = \frac{n e^2 \tau}{m}$$

Drude conductivity

Electron rotates its spin only during time intervals when it tunnels between the sites

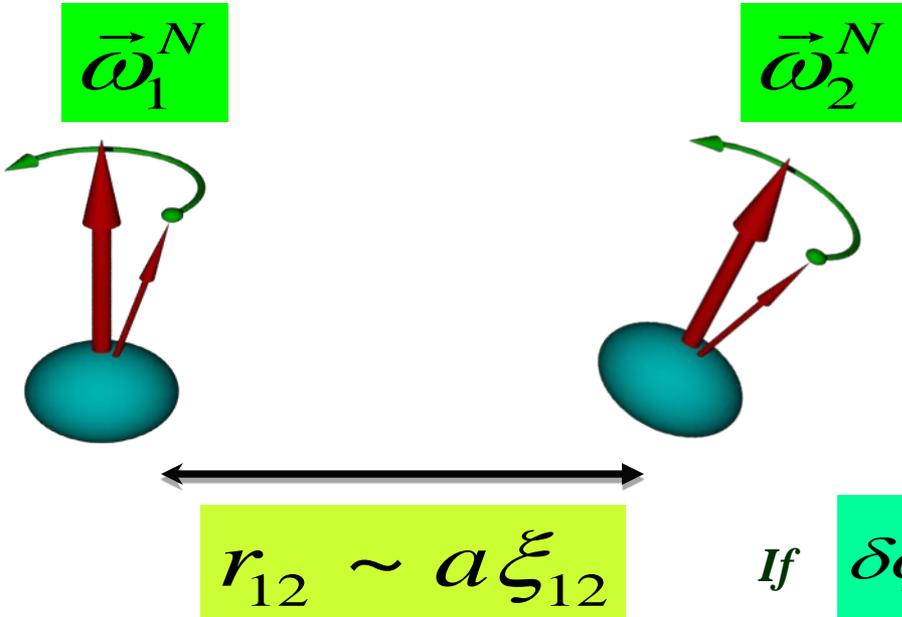
$$\tau_s = N \tau_{hop} = \frac{|\tau_{tun}|}{(\delta\phi)^2} \left(\frac{\tau_{hop}}{|\tau_{tun}|} \right) = \frac{1}{\Omega_{so}^2 |\tau_{tun}|} \left(\frac{\tau_{hop}}{|\tau_{tun}|} \right) \propto \sigma_{hop}^{-1}$$

waiting time

tunneling time

$$\propto \sigma_{hop}^{-1}$$

For localized electron the dominant mechanism of spin relaxation is interaction with random hyperfine field created by nuclei inside the donor orbit



unlike SO-coupling, electron spin precesses while electron **waits for the hop**

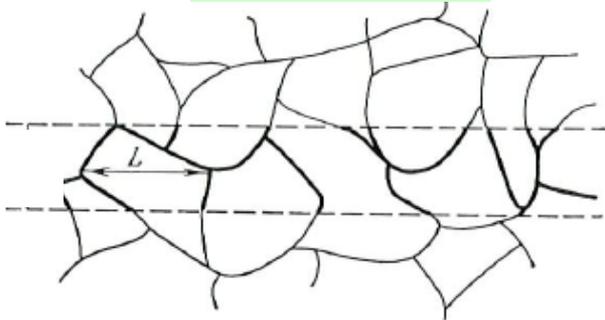
$$\delta\varphi = \omega^N \tau_{hop} = \omega^N \tau_0 \exp(\xi_{12}) \gg 1$$

spin rotation is dominated by most resistive hops

If
$$\delta\varphi_c = \langle (\omega^N)^2 \rangle^{1/2} \tau_0 \exp(\xi_c) \gg 1$$

the initial spin orientation is “forgotten” at distances less than $L_c \sim a \xi_c^{\nu+1}$

If $\delta\varphi_c \ll 1$ initial spin orientation will be “forgotten” at the diffusion stage



$$l_s = \frac{L_c}{\delta\varphi_c} \sim \frac{L_c \exp(-\xi_c)}{\omega^N \tau_0}$$

spin diffusion length contains **correlation radius** of infinite cluster

